

**GigaDevice Semiconductor Inc.**

**Differences between GD32L235 and  
GD32L233 products**

**Application Note**

**AN179**

Revision 1.0

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## 1. Introduction

This application note introduces the characteristic differences between GD32L235 and GD32L233 product series, mainly for electric characteristics and peripheral function characteristics. The differences are described in the following paragraphs.

## 2. **Electric characteristic differences**

For details about the electrical characteristics, refer to the GD32L233xx Datasheet and GD32L235xx Datasheet.

### 3. Peripheral function differences

#### 3.1. Flash memory controller (FMC)

The FMC function differences are reflected in the programming width, fast programming, Flash ECC function, page size and LVE sequence, which refers to [Table 3-1. Differences of FMC function](#).

**Table 3-1. Differences of FMC function**

Part Numbers	Programming width	Fast program	Flash ECC check	Page size	LVE sequence
GD32L233xx	32bit	Supported	Not supported	4KB(GD32L233xC) 2KB(GD32L233xB) 1KB(GD32L233x8)	Supported
GD32L235xx	64bit	Not supported	Supported	1KB	Not supported

#### 3.2. Power management unit (PMU)

The PMU function differences are reflected in the NPLDO supplies, power saving modes, EFLASH power domain configuration and COREOFF1 power domain configuration, which refers to [Table 3-2. Differences of PMU function](#).

**Table 3-2. Differences of PMU function**

Part Numbers	NPLDO supplies	Power saving modes	EFLASH power domain	COREOFF1 power domain
GD32L233xx	1.1V / 0.9V (configurable)	Run, Run1, Run2, Sleep, Sleep1, Sleep2, Deep-sleep, Deep-sleep 1, Deep-sleep 2 and Standby mode	Not configurable	Configurable
GD32L235xx	1.1V	Run, Sleep, Deep-sleep, Deep-sleep 1, Deep-sleep 2 and Standby mode	Configurable	Not configurable

#### 3.3. Reset and clock unit (RCU)

The RCU function differences are reflected in the selection of the system clock (CK\_SYS) source, which refers to [Table 3-1. Differences of FMC](#).

**Table 3-3. Differences of RCU function**

Part Numbers	Select the system clock source
GD32L233xx	CK_IRC16M / CK_HXTAL / CK_PLL / CK_IRC48M
GD32L235xx	CK_IRC16M / CK_HXTAL / CK_PLL / CK_IRC48M / CK_IRC32K

### 3.4. Analog to digital converter (ADC)

The ADC function differences are reflected in the Single-ended and differential input channels, external trigger configuration and the internal temperature sensor output voltage ( $V_{\text{temperature}}$ ), which refers to [Table 3-4. Differences of ADC.](#)

**Table 3-4. Differences of ADC function**

Part Numbers	Single-ended and differential input channels	External trigger configuration	Internal temperature sensor output voltage ( $V_{\text{temperature}}$ )
GD32L233xx	Not supported	Not supported	Temperature ( $^{\circ}\text{C}$ ) = $((V_{30} - V_{\text{temperature}}) / \text{Avg\_Slope}) + 30$
GD32L235xx	Supported	Supported	Temperature ( $^{\circ}\text{C}$ ) = $((V_{25} - V_{\text{temperature}}) / \text{Avg\_Slope}) + 25$

**Note:**  $V_{30} / V_{25}$ : Internal temperature sensor output voltage at  $30^{\circ}\text{C} / 25^{\circ}\text{C}$

### 3.5. Low power timer (LPTIMER)

The LPTIMER function differences are reflected in the counter width, which refers to [Table 3-5. Differences of LPTIMER function](#)

**Table 3-5. Differences of LPTIMER function**

Part Numbers	Counter width
GD32L233xx	32bit
GD32L235xx	16bit

### 3.6. VREF

The VREF function differences are reflected in the internal reference voltage, which refers to [Table 3-6. Differences of VREF function.](#)

**Table 3-6. Differences of VREF function**

Part Numbers	Reference voltage
GD32L233xx	2.5V
GD32L235xx	2.5V / 1.5V (configurable)

### 3.7. Segment LCD controller (SLCD)

The SLCD function differences are reflected in the enhance mode and Internal voltage source, which refers to [Table 3-7. Differences of SLCD function.](#)

**Table 3-7. Differences of SLCD function**

Part Numbers	Enhance mode	Internal voltage source
GD32L233xx	Supported	Use an internal charge pump
GD32L235xx	Not supported	Use the VDD voltage

### 3.8. Universal Serial Bus full-speed device interface (USBD)

The USB D function differences are reflected in the clock frequency requirements and endpoint buffers, which refers to [Table 3-8. Differences of USB D function](#).

**Table 3-8. Differences of USB D function**

Part Numbers	Clock frequency requirements	Endpoint buffers
GD32L233xx	CK_APB1 $\geq$ 24MHz	USBD has the dedicated 512-byte SRAM memory
GD32L235xx	CK_APB1 $\geq$ 12MHz	USBD and CAN share the dedicated 512-byte SRAM memory



## 4. Other differences

### 4.1. Memory

Memory size difference refers to [Table 4-1. Differences of memory size.](#)

**Table 4-1. Differences of memory size**

Part Numbers	FLASH	SRAM
GD32L233xx	Up to 256KB	Up to 32KB
GD32L235xx	Up to 128KB	Up to 24KB

### 4.2. Number of peripherals

Number of peripherals difference refers to [Table 4-2. Differences of number of peripherals.](#)

**Table 4-2. Differences of number of peripherals**

Part Numbers	CAN	LPUART	LPTIMER	TIMER
GD32L233xx	None	LPUART	LPTIMER	TIMER1/2/5/6/8/11
GD32L235xx	CAN	LPUART0/1	LPTIMER0/1	TIMER0/1/2/5/6/8/11/14/40

### 4.3. SRAM parity check function

SRAM parity check function difference refers to [Table 4-3. Differences of SRAM parity check.](#)

**Table 4-3. Differences of SRAM parity check**

Part Numbers	SRAM parity check function
GD32L233xx	Not supported
GD32L235xx	Supported

## 5. Revision history

Table 5-1. Revision history

Revision No.	Description	Date
1.0	Initial Release	Apr.2, 2024

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